

June 2007

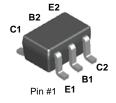
# **BC847BS**

# **NPN Multi-chip General Purpose Amplifier**

This device is designed for general purpose amplifier applications at collector currents to 200 mA. Sourced from Process 07.

**Dual NPN Signal Transister** 

SC70-6 Mark: .1F



NOTE: The pinouts are symmetrical; pin 1 and pin 4 are interchangeable. Units inside the carrier can be of either orientation and will not affect the functionality of the device.

## Absolute Maximum Ratings \*Ta = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
V <sub>CBO</sub>	Collector-Base Voltage	50	V
V <sub>CES</sub>	Collector-Base Voltage	50	V
V <sub>CEO</sub>	Collector-Emitter Voltage	45	V
V <sub>EBO</sub>	Emitter-Base Voltage	6.0	V
I <sub>C</sub>	Collector Current (DC)	100	mA
T <sub>J</sub> , T <sub>STG</sub>	Junction Temperature and Storage Temperature	-55 ~ <b>+</b> 150	°C

<sup>\*</sup> These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

### NOTES:

## Thermal Characteristics \*T<sub>a</sub> = 25°C unless otherwise noted

Symbol	Characteristic	Max	Units	
PD	Total Device Dissipation	210	mW	
	Derate above 25°C	1.6	mW/°C	
<b>R</b> $\Theta$ ЈА	Thermal Resistance, Junction to Ambient	625	°C/W	

<sup>\*</sup>Device mounted on FR-4 PCB 1.6" X 1.6" X 0.06".

<sup>1)</sup> These ratings are based on a maximum junction temperature of 150 degrees C.

<sup>2)</sup> These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.

# Electrical Characteristics \* T<sub>a</sub> = 25°C unless otherwise noted Parameter

Off Characteristics					
V <sub>(BR)CBO</sub>	Collector-Emitter Breakdown Voltage	Ic = 10 μA, Iε = 0	50		V
V <sub>(BR)</sub> CES	Collector-Base Breakdown Voltage	Ic = 10 μA, Iε = 0	50		V
V <sub>(BR)CEO</sub>	Collector-Base Breakdown Voltage	Ic = 10 mA, I <sub>B</sub> = 0	45		V
V <sub>(BR)EBO</sub>	Emitter-Base Breakdown Voltage	$I_E = 10 \mu A, I_C = 0$	6.0		V
Ісво	Collector-Cutoff Current	Vcb = 30 V, IE = 0 Vcb = 30 V, IE = 0, TA = 150°C		15 5.0	nA μA

**Test Condition** 

MIN

MAX

Units

## **On Characteristics**

Symbol

hfe	DC Current Gain	Ic = 2.0 mA, VcE = 5.0 V	200	450	
VcE(sat)	Collector-Emitter Saturation Voltage *	Ic = 10 mA, I <sub>B</sub> = 0.5 mA Ic = 100 mA, I <sub>B</sub> = 5.0 mA		0.25 0.65	V V
V <sub>BE</sub> (on)	Emitter-Base Breakdown Voltage *	Ic = 2.0 mA, VcE = 5.0 V Ic = 10 mA, VcE = 5.0 V	0.58	0.7 0.77	V V

<sup>\*</sup> Pulse Test: Pulse Width≤300μs, Duty Cycle≤2%

NOTE: All voltages (V) and currents (A) are negative polarity for PNP transistors.





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